

Electric field control of the skyrmion Hall effect in piezoelectric/magnetic devices

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Abstract

Relying on both electromechanical and micromagnetic simulations, we propose a method to control the trajectory of current-driven skyrmions using electric field in hybrid piezoelectric/magnetic systems. By applying a voltage between two lateral electrodes a transverse strain gradient is created as a result of the non-uniform electric field profile in the piezoelectric. Due to magnetoelastic coupling, this transverse gradient leads to a lateral force on the skyrmions that can be used to suppress the skyrmion Hall angle for any given current density if proper voltage is applied. We show that this method works under realistic conditions, such as the presence of disorder in the ferromagnet, and that skyrmion trajectories can be controlled with moderate voltages. Moreover, our method allows for increasing the maximum current density that can be injected before the skyrmion is annihilated at the nanostrip edge, which leads to an increase in the maximum achievable velocities.

Keywords: Skyrmion, Electric Field, Micromagnetic modelling, Electromechanical modelling.

Introduction

Since their observation in 2009 [1], magnetic skyrmions have attracted a lot of attention, not only from the point of view of fundamental research, but also because they present some features, such as small size, topological protection or being sensitive to moderate current densities, that make them attractive for the development of the next generation of spintronic devices. In this sense, different skyrmion-based devices have been proposed, such as logic gates [2-5], magnetic memories [6,7], artificial neuron spikes [8,9] or microwave detectors [10]. The potential success of these devices relies on our capacity for nucleating, stabilizing and controlling the motion of skyrmions in an energy efficient way.

Magnetic skyrmions can be moved using spin-polarized electrical currents [11], anisotropy gradients [12], strain gradients [13], surface acoustic waves [14], magnetic field gradients [15], spin waves [16], temperature gradients [17], etc. Regardless of the nature of the driving force, the skyrmion trajectory is not parallel to the direction of this force but it deviates a certain angle from it [18], a phenomenon usually referred to as Skyrmion Hall effect (SkHE) [19-22]. This universal phenomenon is due to the gyrotropic nature of magnetization dynamics, which leads to the appearance of a force on the skyrmion perpendicular to the driving one, the so-called Magnus force [23]. This is detrimental for the design of skyrmion-based devices, such as racetracks memories, where skyrmions are intended to follow a straight path along the nanostrip. Consequently, different approaches have been proposed to avoid it. For example, SkHE should not be present in antiferromagnets [24, 25] because the skyrmion's gyrovector cancels out but, as far as we are concerned, the nucleation of isolated skyrmions in antiferromagnets has not been reported so far. The SkHE is also absent in Synthetic antiferromagnets (SAF)

[26] because the two interlayer-coupled skyrmions exhibit antiparallel Magnus forces that cancel each other but, although isolated skyrmions have been stabilized in SAF [27], their controlled motion by electrical current or by any other means is still in a premature state [28]. Other more exotic textures, like magnetic Skyrmioniums, should also move without SkHE, since their topological charge is roughly zero [29, 30].

Tuning the skyrmion intrinsic properties is not the only way to suppress the SkHE. An alternative approach is based on inducing an external force to compensate the Magnus force. Different methods have been proposed along this line. In fact, in narrow strips the skyrmion is repelled by the edges and this repulsive transverse force is useful to maintain the skyrmion moving straight along the track [31]. On the other hand, it was shown that by engineering Rashba and Dresselhaus Spin Orbit couplings it is possible to suppress the skyrmion Hall angle for both Neel skyrmions and Bloch antiskyrmions [32]. Heavy metal layers with reduced symmetry in chiral multilayers is also a route to minimize the skyrmion Hall angle and to maximize its speed via partial current polarization in such systems [33]. In any case, other methods providing more freedom and versatility to manipulate skyrmion motion are desirable to develop new technologies. In the present work we propose an approach for this purpose. It is based on a transverse voltage-induced mechanical excitation of a piezoelectric layer attached to the ferromagnetic nanostrip which, due to magnetoelastic coupling, creates a transverse force on the skyrmion that can be used to totally suppress the skyrmion Hall angle and to increase its velocity.

In the next section we present and discuss the results on which our proposal is based. We will firstly study the electromechanical response of our system and characterize, both qualitatively and quantitatively, the strain profile transferred to the ferromagnetic nanostrip along which the skyrmions move. Secondly, we use both micromagnetic simulations and Thiele's model [34] to show that this strain profile creates a transverse

force on the skyrmion that can be used to correct its trajectory when driven by a current flowing parallel to the nanostrip. Moreover, we derive the condition to suppress the skyrmion Hall angle for any given value of the current density. In the last part we show that our approach works under realistic conditions, such as the presence of disorder in the sample, and that it can be used to increase the maximum achievable skyrmion velocities.

Results and Discussion

A sketch of the device proposed is presented in Fig.1(a), where skyrmions move along a perpendicularly magnetized ferromagnetic (FM) racetrack driven by a current passing through an adjacent heavy metal (HM). The HM/FM/Oxide trilayer is grown on top of a thick piezoelectric (PZ) film with two extended lateral electrodes on top of it, as shown in the figure. The basic idea of our proposal is that, due to magneto-elastic coupling, the strain created in the system when a voltage is applied between these two electrodes leads to a force on the skyrmions that can be used to control of their lateral motion.

Electromechanical simulations were performed using COMSOL Multiphysics [35]. As piezoelectric material we used PZT-4 (Lead Zirconate Titanate) of dimensions $\ell_{\text{PZ}} = 1200 \text{ nm}$, $w_{\text{PZ}} = 1000 \text{ nm}$ and $t_{\text{PZ}} = 100 \text{ nm}$ (see Fig.1(a)), whereas for the HM/FM/Oxide we considered Pt[2nm]/CoFeB[1nm]/MgO[1nm] with lateral dimensions $\ell_{\text{FM}} = 1024 \text{ nm}$, $w_{\text{FM}} = 500 \text{ nm}$ and the following values for Young modulus and Poisson ratio: $Y_{\text{Pt}} = 154 \text{ GPa}$, $\nu_{\text{Pt}} = 0.385$ [36], $Y_{\text{CoFeB}} = 162 \text{ GPa}$, $\nu_{\text{CoFeB}} = 0.3$ [37], $Y_{\text{MgO}} = 270 \text{ GPa}$ and $\nu_{\text{MgO}} = 0.35$ [38]. When calculating the electromechanical response, we assume that the PZ bottom surface is clamped to the substrate and we consider the conductive nature of both FM and HM layers.

Fig. 1(b) shows the electric field lines in the PZ in the device cross section. As can be observed, the field lines leak into the HM layer due to its conductive nature, yielding a highly non-uniform field pattern. In particular, we note the profile of the out-of-plane component E_z along the PZ/HM interface in the transversal direction, which is plotted in Fig.1(c) for an applied voltage of 10 V between the electrodes. As can be noticed, the field strength is maximum at the edges, but it points in opposite directions, and a gradual non-linear transition between these two extreme values is obtained as we move from one edge to the other. The profile along the central region, shown in the inset of Fig. 1(c), is approximately linear with a slope $\frac{dE_z}{dy} \sim 10 \text{ V}/\mu\text{m}^2$.

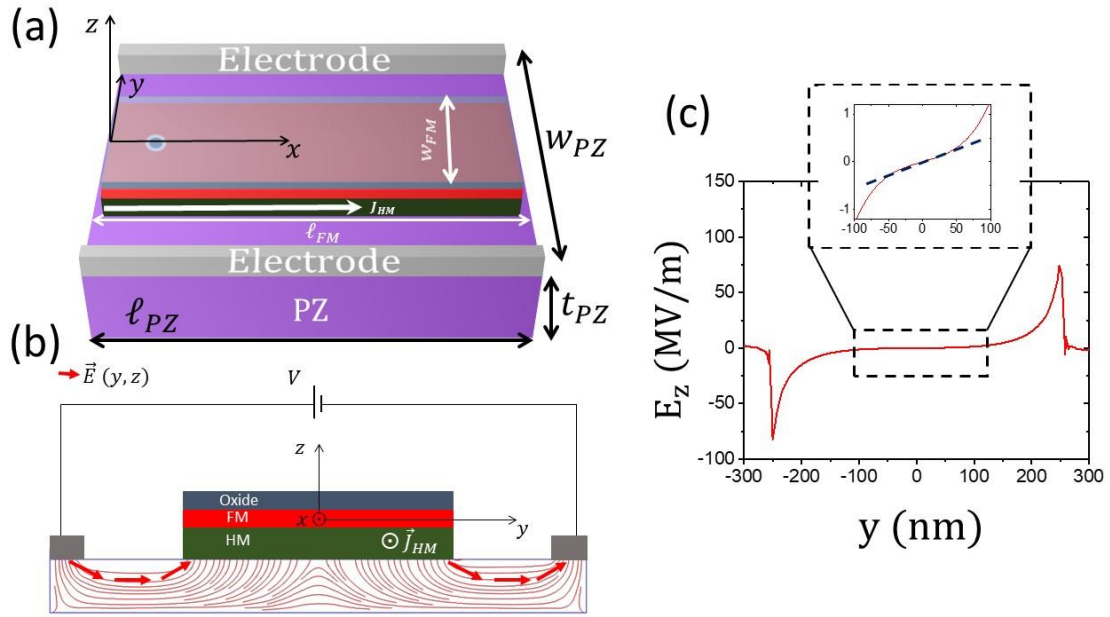


Fig.1: (a) Schematic representation of the simulated device. (b) Device cross section showing the electric field lines in the PZ substrate. (c) Profile of the vertical component E_z along the PZ/HM interface. The inset zooms out the profile in the central region of the nanostrip.

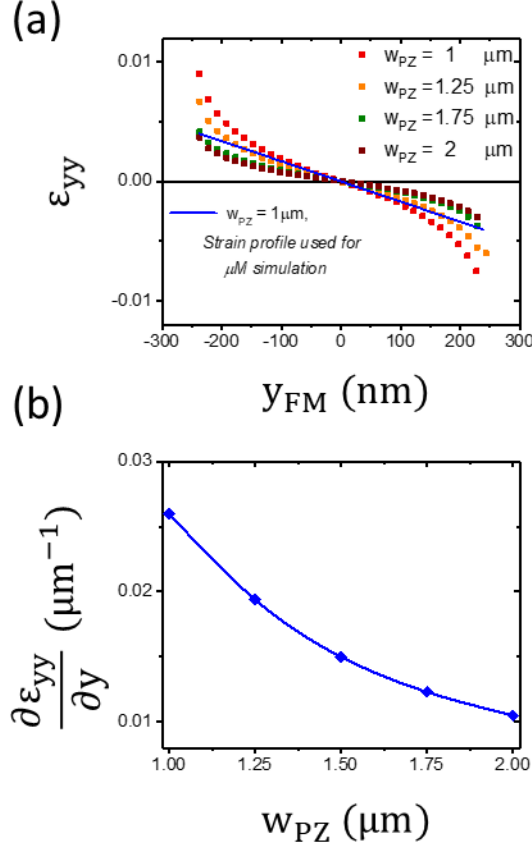


Fig.2: (a) Elastic strain (ϵ_{yy}) profile transferred to the FM layer across the central region for different PZ layer widths. The blue line represents a linear profile obtained by extrapolating the slope at the origin ($y = 0$) for $w_{PZ} = 1 \mu m$. (b) Strain gradient in the center of the FM ($y = 0$) for different PZ layer widths w_{PZ} . A voltage $V = 10$ V between the electrodes is applied in all cases.

The strain distribution in the device as a response of the PZ substrate to the electric field is also calculated with COMSOL Multiphysics [35]. In particular, Fig.2(a) shows the profile of the strain component ϵ_{yy} transferred from the PZ to the FM for different widths of the PZ substrate. As can be observed, a smooth quasi-linear profile changing sign across the central point of FM is obtained in all cases. This strain profile can be understood by looking at the electric field in Fig. 1(c) and considering that, in the absence of external stress, we have $\epsilon_{yy} = d_{13}E_z$, where $d_{13} = -1.23 \times 10^{-10} \text{ C N}^{-1}$ in our case [35]. Other factors, such as residual stresses due to substrate clamping [39], also affect the strain, but their contribution is small. In Fig. 2(b) the strain gradient at the center ($y =$

0) as a function of w_{PZ} is plotted. The gradual decrease is a consequence of the electric field scaling with the inverse of the distance between electrodes (w_{PZ}^{-1}).

To sum up, our electromechanical simulations show that by applying moderate voltages between the electrodes it is possible to create strain gradients in the central region of the FM racetrack in the order $10^{-2} \mu\text{m}^{-1}$. Moreover, the magnitude of the gradient can be controlled with the applied voltage and the distance between the electrodes.

Once we have characterized the mechanical response of the device, in what follows we will investigate how this can be used to control the lateral motion of skyrmions in our system. To do that we perform micromagnetic simulations of a skyrmion driven by a current flowing through the HM layer (Fig. 1(a)) and in the presence of a transverse strain gradient $\frac{d\varepsilon_{yy}}{dy}$. Simulations are carried out using a GPU-based in-home modified version of Mumax³ that includes a magneto-elastic contribution to the effective field [40,13] given by

$$\vec{H}_{me} = \frac{1}{\mu_0 M_s} \sigma_{ij} \frac{\delta \varepsilon_{ij}^m}{\delta \vec{m}} \quad (1)$$

where σ_{ij} and ε_{ij}^m are the stress and magnetic strain tensors, respectively, M_s is the saturation magnetization, μ_0 the vacuum permeability and $\vec{m}(r, t) = \frac{\vec{M}(r, t)}{M_s}$ the reduced magnetization. The Landau-Lifshitz-Gilbert dynamic equation is augmented with Slonczewski-like spin-orbit torque that takes into account the contribution of the current flowing through the HM [41, 42]. The following material parameter values, typical of Oxide/CoFeB/HM multilayers [43-47], were used in the micromagnetic simulations: $A_{ex} = 20 \text{ pJ/m}$ (exchange stiffness), $M_s = 1 \text{ MA/m}$ (saturation magnetization), $K_u = 0.8 \text{ MJ/m}^3$ (uniaxial anisotropy), $D_{int} = 1.8 \text{ mJ/m}^2$ (interfacial Dzyaloshinskii–

Moriya), $\lambda_s = 3.7 \times 10^{-5}$ (magnetostriction), $\alpha = 0.3$ (damping constants) and $\theta_{SH} = -0.33$ (spin Hall angle).

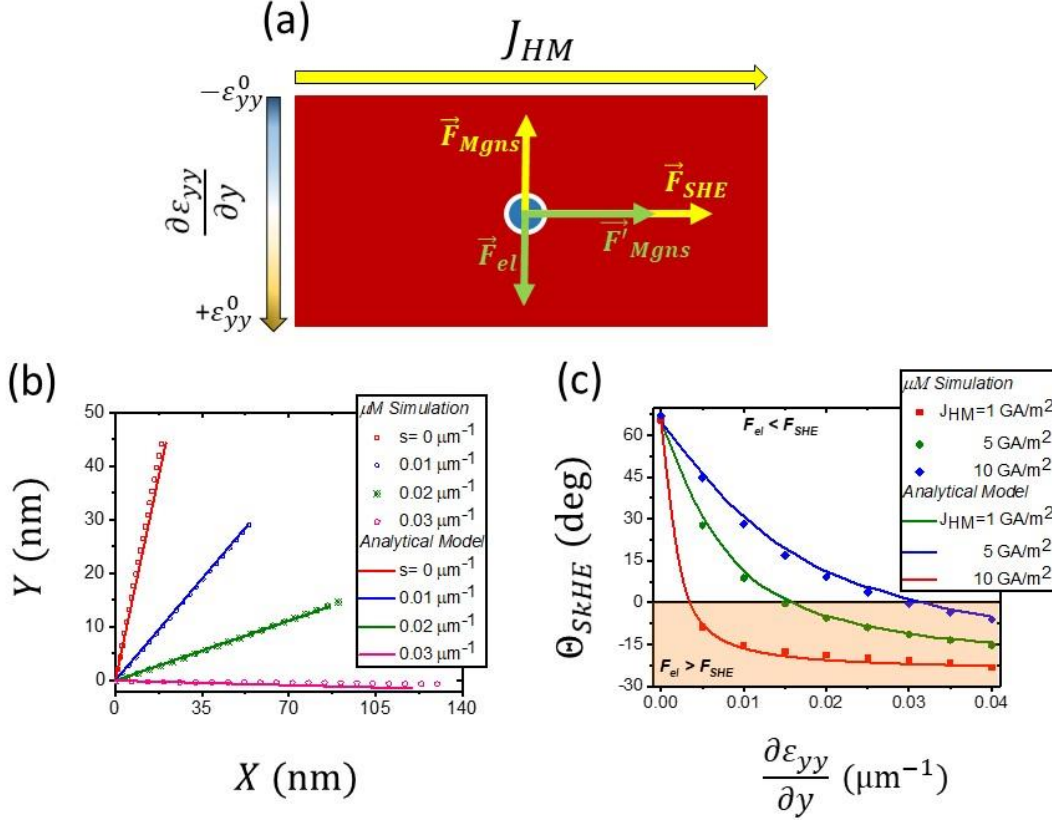


Fig.3: (a) Schematic representation of the force contributions on the skyrmion dynamics. (b) Skyrmion trajectories obtained from micromagnetic simulations (dots) and analytical calculations (lines) for a current density $J_{HM} = 10 \text{ GA/m}^2$ and different strain gradients. In the legend, “s” stands for “strain gradient”, $s \equiv \frac{d\epsilon_{yy}}{dy}$. (c) Evolution of the skyrmion Hall angle with the strain gradient for different current density values.

Fig. 3 shows the effect of the transversal strain gradient on the skyrmion dynamics. In Fig. 3(b) we plot the skyrmion trajectory for an applied current density 10 GA/m^2 and different values of the strain gradient $\frac{d\epsilon_{yy}}{dy}$. As can be observed, the skyrmion Hall angle decreases as the strain gradient is increased. This trend is confirmed in Fig. 3(c), where the skyrmion Hall angle is plotted as a function of the strain gradient for three different

applied current densities, showing a monotonous decrease in all cases. The strain gradient, therefore, creates a force that pushes the skyrmion towards regions of higher strain. The origin of this force, which was analyzed in [13], lies on the fact that the skyrmion energy is reduced as the strain increases. This force, \vec{F}_{el} , is schematically represented in Fig. 3(a) (green) together with the driving force exerted by the current \vec{F}_{SHE} (yellow). Their associated skyrmion Magnus forces, \vec{F}_{Mgns} and \vec{F}'_{Mgns} , are also represented. Skyrmion dynamics in our system can be understood in terms of these four forces acting on it.

In addition to micromagnetic simulations, the well-known Thiele's model [34] can also give us useful information. In particular, analytical expressions for the forces involved can be derived. According to this model, under the action of \vec{F}_{el} and \vec{F}_{SHE} the skyrmion equation of motion is given by [34]

$$\vec{G} \times \vec{V} + \alpha \bar{D} \vec{V} = \vec{F}_{SHE} + \vec{F}_{el} \quad (2)$$

where $\vec{G} = -4\pi (N_{sk}) \frac{\mu_0 M_s}{\gamma_0} t_{FM} \vec{e}_z$ is the gyro-vector with $N_{sk} = -1$ the skyrmion

number, \vec{V} is the skyrmion velocity and $\bar{D} = \begin{pmatrix} D_{xx} & D_{xy} \\ D_{yx} & D_{yy} \end{pmatrix}$ is the dissipation tensor with

$$D = D_{xx} = D_{yy} = -\frac{\mu_0 \pi M_s}{2\gamma_0} t_{FM} (\pi^2 - \text{Ci}(2\pi) + \gamma_E + \log(2\pi)), \quad \text{and } D_{xy} = D_{yx} = 0,$$

with Ci and γ_E being the cosine integral function and Euler constant, respectively.

The force due to the Spin-Hall effect is given by $\vec{F}_{SHE} = \frac{\hbar \theta_{SH} J_{HM}}{2|e|} \pi^2 \eta \frac{\Delta}{2} \vec{e}_x$, where θ_{SH} is

the spin Hall angle, J_{HM} is the current density through the HM, $\Delta = 31$ nm is the skyrmion wall width, e is the electron charge and η is a fitting parameter. On the other

hand, the force due to the strain gradient is given by [13] $\vec{F}_{el} = \frac{3\pi \Delta^2 \lambda_s}{8} t_{FM} (C_{11} +$

$C_{12}) \frac{\partial \varepsilon_{yy}}{\partial y} \vec{e}_y$, where λ_s is the magnetostriction, $C_{11} = \frac{Y(1-\nu)}{(1+\nu)(1-2\nu)}$ and $C_{12} = \frac{\nu Y}{(1+\nu)(1-2\nu)}$

are the elastic constants and t_{FM} is the ferromagnetic layer thickness. All these terms were calculated using the zero radius skyrmion ansatz described in [13].

From Eq. (2) the longitudinal and transversal components of the skyrmion velocity are given by

$$V_x = \frac{\alpha D F_{SHE} + G F_{el}}{\alpha^2 D^2 + G^2} \quad (3)$$

$$V_y = \frac{-G F_{SHE} + \alpha D F_{el}}{\alpha^2 D^2 + G^2} \quad (4)$$

so that the skyrmion Hall angle is given by

$$\theta_{SkHE} = \tan^{-1} \left(\frac{-G F_{SHE} + \alpha D F_{el}}{\alpha D F_{SHE} + G F_{el}} \right) \quad (5)$$

In Figs. 3(b) and 3(c), we show the predictions of the model (solid lines) together with the results of micromagnetic simulations (symbols). The same parameter values have been used in both of them with $\eta = 1.05$ as the only fitted parameter in Thiele's model. As can be observed, good quantitative agreement is found, which indicates that Thiele's model captures the most relevant features of skyrmion dynamics in our system. The discrepancies between the simulations and the model are mainly attributed to the fact that the skyrmion diameter depends on the strain [13, 48] and, therefore, its diameter changes as it moves in the presence of a strain gradient, a feature not considered in Thiele's model.

Moreover, we can extract from the model the condition that needs to be satisfied for the skyrmion to move straight along the nanostrip without transversal deflection. By making either $V_y = 0$ in Eq. (4) or $\theta_{SkHE} = 0$ in Eq. (5) we obtain

$$F_{el} = \frac{G}{\alpha D} F_{SHE} \quad (6)$$

as the condition that guarantees the suppression of the skyrmion Hall effect. Using Eq. (6) and the expressions of F_{SHE} and F_{el} given above, we can obtain, for any given current density J_{HM} , the value of the strain gradient $\frac{\partial \varepsilon_{yy}}{\partial y}$ needed to cancel the skyrmion Hall effect:

$$\frac{\partial \varepsilon_{yy}}{\partial y} = \frac{2\pi \eta G \hbar \theta_{SH}}{3\alpha D |e| \Delta \lambda_s t_{FM} (C_{11} + C_{12})} J_{HM} \quad (7)$$

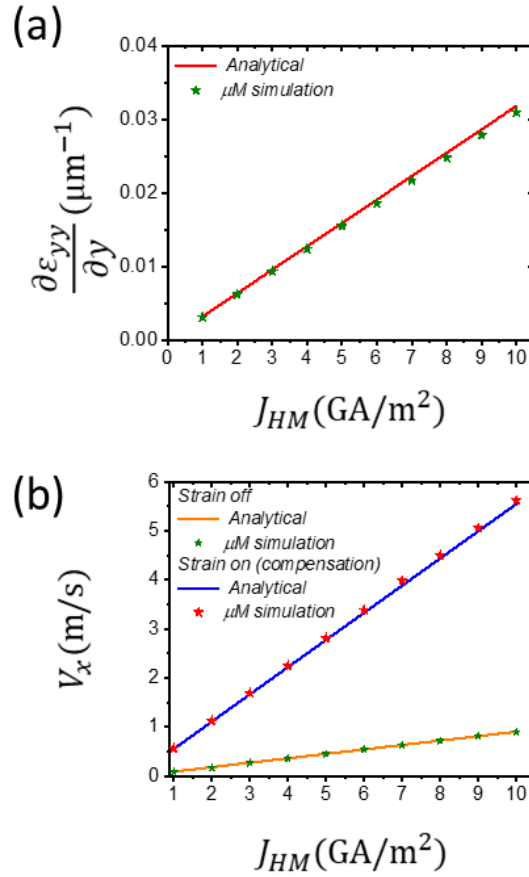


Fig.4: (a) Strain gradient slope required to compensate the skyrmion Hall angle for each current density J_{HM} value. (b) Skyrmion speed versus applied current in the absence of strain and in present of a strain compensating the skyrmion Hall angle.

Fig. 4(a) shows the value of the strain gradient that cancels the skyrmion Hall effect for different values of the applied current density as obtained from micromagnetic simulations (green symbols) and from Eq. (7) (red line). Again, an excellent agreement

is found between them. The discrepancies are even smaller than in Figs. 3(b) and (c) because now the skyrmion moves horizontally, perpendicularly to the strain gradient and, therefore, its diameter does not change during motion [13, 48].

On the other hand, in Fig. 4(b) we plot the skyrmion speed as a function of the current density obtained from micromagnetic simulations both without strain gradient (green symbols) and with the strain gradient that cancels the skyrmion Hall effect (red symbols). The corresponding values obtained from Thiele's model are also shown with solid lines (orange and blue, respectively). As can be observed, a linear increase in the longitudinal velocity (V_x) is obtained in both cases, but the speed values are remarkably higher when the strain gradient is included. This can be understood by considering that \vec{F}'_{Mgns} , the Magnus force associated to \vec{F}_{el} , points along the positive x axis (see Fig. 3(a) and Eq. (3)) and, as a result, it adds up to \vec{F}_{SHE} increasing the total force pushing the skyrmion along the nanostrip. Therefore, by choosing the appropriate value of the strain gradient, which depends linearly on the applied voltage, it is possible not only to suppress the skyrmion Hall effect but also to increase its velocity significantly.

Up to now we have shown that our scheme for tuning the skyrmion Hall angle works for idealized samples, but it remains to be shown if it would also work in real samples, where intrinsic pinning due to structural disorder is known to play an important role in skyrmion dynamics [49]. With that goal in mind, we carried out simulations with the same geometry and material parameter values described before but now including disorder [50]. Disorder is modeled via a Voronoi tessellation of the film in polygonal regions of average diameter $d = 5$ nm, where both anisotropy constant and easy-axis orientation are different for each grain following a Gaussian distribution around their nominal values, $K_u = 0.8$ MJ/m³ and $\vec{u}_k = \{0,0,1\}$, with standard deviation $\sigma = 2\%$ [51]. The results are shown in Fig. 5

together with those carried out in the absence of disorder for an applied current density $J_{HM} = 30 \text{ GA/m}^2$. This value is well above the range investigated in Fig. 3 because we are mainly interested in the flow regime [49, 52].

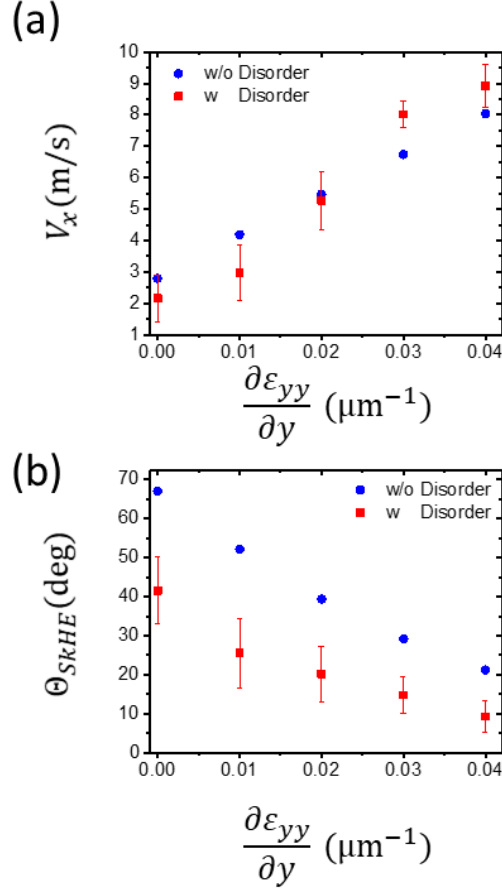


Fig.5: (a) Skyrmion speed versus strain gradient for a disordered FM film (red dots) and for an ideal FM film (blue dots). (b) Skyrmion hall angle evolution versus the strain gradient for a disordered FM film (red dots) and for an ideal FM film (blue dots). The graphs show a comparison between a disordered and ideal film in presence of a current density $J_{HM} = 30 \text{ GA/m}^2$.

Both the skyrmion speed (Fig. 5(a)) and skyrmion Hall angle (Fig. 5(b)) as a function of the strain gradient are plotted. In the simulations with disorder (red squares) the results are obtained by averaging over 10 realizations, each one with a different grain distribution. As can be observed in Fig. 5(a), the increase in the skyrmion speed with the strain gradient remains in the presence of disorder. On the other hand, disorder leads to a

reduction in the skyrmion Hall angle (Fig. 5(b)) [52-55], but also a monotonous decrease with the strain gradient is obtained, as it is the case without disorder. Animations of the skyrmion motion in presence of disorder are presented in the supplemental material [56].

Although the results shown in the manuscript were carried out without considering thermal fluctuations in the simulations, some trials were made at a finite temperature and the results did not show a significant effect on the skyrmion hall angle for the current density range considered. In a recent publication [57] it was shown that the skyrmion Hall angle is not significantly affected by temperature unless a high-flow regime is reached where some distortion on the skyrmion structure takes place. A previous computational study [58] showed that the effect of temperature on the skyrmion Hall angle is most pronounced at small drives where thermally-induced depinning occurs, whereas in the flow regime it slightly increases with temperature.

As pointed out before, in narrow nanostrips the edges exert a repulsive force on the skyrmions that affect their dynamics. In particular, this force increases as the skyrmion deviates from the center ($y = 0$) and, at some point, it compensates the Magnus force due to the current and the skyrmion ends up in a horizontal trajectory at a given distance y_{term} from the nanostrip central axis. However, for current densities above a certain critical value J_c , the edge repulsion is not strong enough to compensate the magnus force and the skyrmion is annihilated at the edge. This critical value, which depends on the nanowire width, limits the current range of the device operability. In this last part of the manuscript we explore how our approach can be used to increase this critical current. To do that we simulate a nanostrip of dimensions $1024 \times 128 \times 1 \text{ nm}^3$, narrower but with the same material parameter values than the one considered before (Fig. 1(a)). Thiele's model was also used by including an additional force in (eq.2) that considers the repulsion from the edges, \vec{F}_{rep} . Following previous works [59], it is modelled as $\vec{F}_{rep} = k Y(t) \vec{e}_y$, where

$k = 3.6 \cdot 10^{-5}$ N/m is an elastic constant estimated from micromagnetic simulations and $Y(t)$ is the skyrmion's transversal position. The dynamic equation Eq. (2) with the new term \vec{F}_{rep} can be solved analytically yielding

$$X(t) = \frac{F_{SHE}}{\alpha D} t + \frac{G^2 F_{SHE} + G \alpha D F_{el}}{\alpha^2 D^2 k} \left(1 - e^{-\frac{t}{\tau}}\right) \quad (8)$$

$$Y(t) = \frac{G F_{SHE} - \alpha D F_{el}}{\alpha D k} \left(1 - e^{-\frac{t}{\tau}}\right) \quad (9)$$

where $\tau = \frac{G^2 + \alpha^2 D^2}{\alpha D k}$ is the characteristic time for the skyrmion response to the edge force.

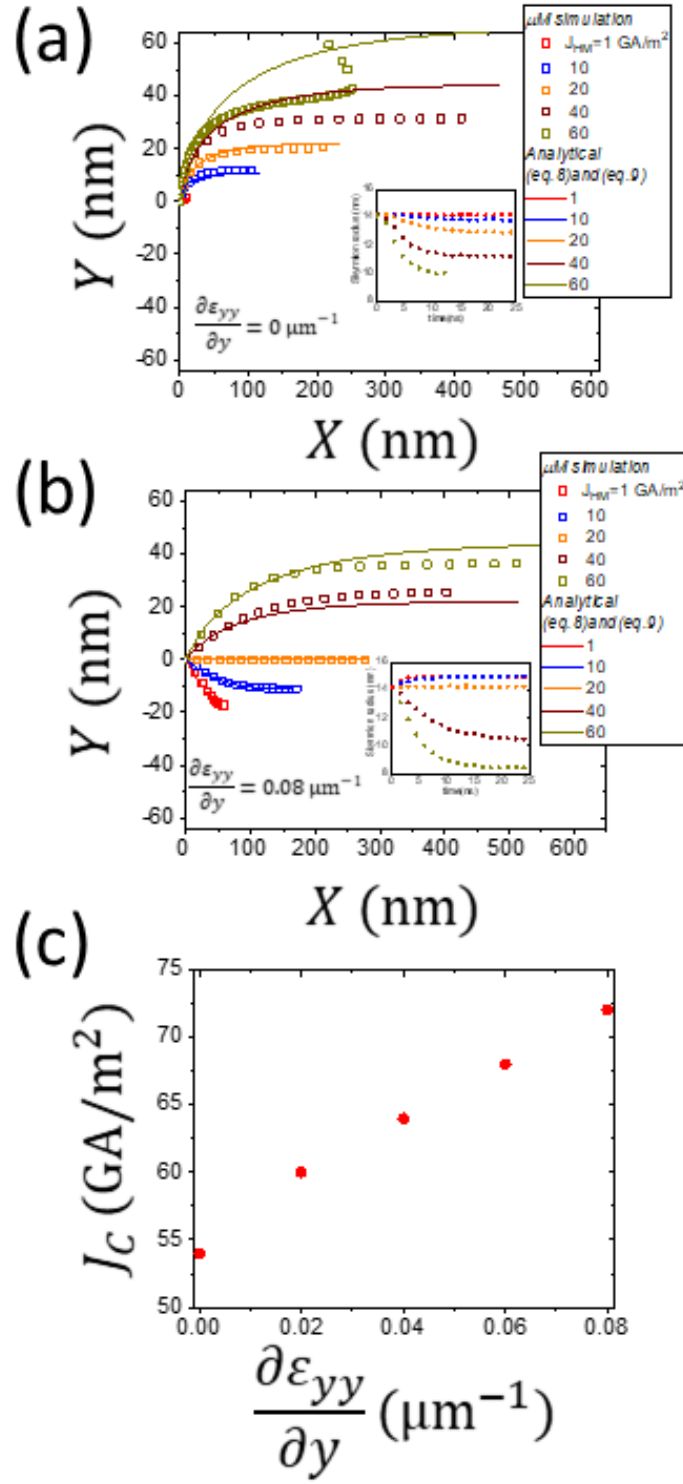


Fig.6: Skymion trajectory for different applied current densities (a) without and (b) in presence of a strain gradient. Both the results of micromagnetic simulations (symbols) and Thiele's model (lines) are shown. The time evolution of the skyrmion radius is shown in the insets. (c) Threshold current for skyrmion annihilation as a function of the strain gradient.

In Fig. 6 we show the skyrmion trajectory for a time window of 25 ns and different values of the applied current density without strain gradient (Fig. 6(a)) and for a strain gradient of $\frac{\partial \varepsilon_{yy}}{\partial y} = 0.08 \mu\text{m}^{-1}$ (Fig. 6(b)). The trajectories obtained from both micromagnetic simulations and Thiele's model are shown. As can be observed in Fig. 6(a), the terminal vertical displacement of the skyrmion increases with the current density and for the largest one, $J_{HM} = 60 \text{ GA/m}^2$, the skyrmion is annihilated when it hits the boundary ($Y = \frac{w_{FM}}{2} = 64 \text{ nm}$). This terminal displacement is significantly reduced when the strain gradient is applied (Fig. 6(b)), up to the point that for the smallest current density values it is negative. This makes it possible for a current of $J_{HM} = 60 \text{ GA/m}^2$ and higher to be injected without the skyrmion being annihilated. Micromagnetic simulation and Thiele's model predict a very similar behavior. The discrepancies between them are mainly attributed to the fact that the skyrmion radius changes as it moves vertically, as shown in the insets of Figs. 6(a) and (b), and also to the fact that the repulsion from the edges is not accurately described with an elastic force when the skyrmion is close to the edge [60]. In Fig. 6(c) we show the maximum current J_c that can be injected without the skyrmion being annihilated at the edge of the nanostrip for different values of $\frac{\partial \varepsilon_{yy}}{\partial y}$. As can be observed, J_c increases with the strain gradient, which proves that our approach can be used to inject higher currents in the nanostrip, with the consequent increase in speed and operating range of the devices.

Conclusions

In conclusion, we showed a route to control the skyrmion trajectory and cancel the skyrmion Hall effect via electric field in hybrid piezoelectric/magnetic multilayers. We investigated the electromechanical response of the device when a voltage is applied between two lateral electrodes, finding a transversal strain gradient in the central part of

the ferromagnetic layer, the amplitude of which is linear with the applied voltage and with the inverse of the distance between the electrodes. Micromagnetic simulations show that such strain gradient leads to a transverse force on the skyrmion that can have a sizable effect on its trajectory when driven by a current. In particular, the skyrmion Hall effect can be cancelled for any given current density if proper voltage is applied. Moreover, the strain gradient contributes to increasing the longitudinal velocity and, in narrow nanostrips, it allows for an increase of the maximum current density that can be injected before the skyrmion is annihilated at the nanostrip edge. Our approach works in realistic conditions, in particular in the presence of structural disorder in the ferromagnet. From a broader perspective, we believe that the applicability of our approach goes beyond the possibility of cancelling the skyrmion Hall angle but it provides additional degrees of freedom to control skyrmion motion, which could have a strong impact in the design of skyrmion-based memories, logic and neuromorphic computing devices.

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